



PTO/SB/08A (08-03)

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Substitute for form 1449/PTO

## **INFORMATION DISCLOSURE STATEMENT BY APPLICANT**

(Use as many sheets as necessary)

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**Complete if Known**

Application Number	10/813,149
Filing Date	March 30, 2004
First Named Inventor	Kevin George Harding
Art Unit	2877
Examiner Name	Unknown
Attorney Docket Number	131103-1/YOD (GERD:0124)

**U. S. PATENT DOCUMENTS**

## **FOREIGN PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	T <sup>2</sup>
		Country Code <sup>3</sup> Number <sup>4</sup> Kind Code <sup>5</sup> (if known)				
YJ	B1	DE 101 04 425 A1	09-20-2001	ISRA Vision Systems AG	claims 1, 9	✓
YJ	B2	EP 0 398 781 A	11-22-1990	Eastman Kodak Co.	claims 1, 9	✓

**Examiner  
Signature**

Methyl stearate

Date  
Considered

3-31-90

**\*EXAMINER:** Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. <sup>1</sup>Applicant's unique citation designation number (optional). <sup>2</sup>See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 801.04. <sup>3</sup>Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language Translation is attached.

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Substitute for form 1449/PTO				<i>Complete if Known</i>	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> <i>(Use as many sheets as necessary)</i>				Application Number	10/813,149
Sheet	2	of	2	Filing Date	March 30, 2004
				First Named Inventor	Kevin George Harding
				Art Unit	2877
				Examiner Name	Unknown
				Attorney Docket Number	131103-1/YOD (GERD:0124)

<b>NON PATENT LITERATURE DOCUMENTS</b>				
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.		
<i>MJ</i>	C1	YAMAZAKI, I. ET AL.; "Microscopy and Analysis of Wafer Particles Using a Semiconductor Defect Review System"; Hitachi Review, Hitachi Ltd., Tokyo, Japan, vol. 45, no 1, February 1, 1996, pgs. 7-10.		
	C2			
	C3			
	C4			

Examiner Signature	<i>Michael Stoll</i>	Date Considered	3-31-06
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Form PTO-1449 (modified)		ATTY. DOCKET NO. 131103-1/YOD (GERD:0124)	SERIAL NO. Unassigned
List of Patents and Publications For Applicant's Information Disclosure Statement  (Use several sheets if necessary)		APPLICANT Kevin George Harding et al.	
		FILING DATE Herewith	GROUP Unassigned

#### U.S. PATENT DOCUMENTS

EXAM. INIT.	REF. DES.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
M	A1	4,998,005	03/05/1991	Rathi et al.	219	121.83	05/15/1989
D	A2	6,522,777	02/18/2003	Paulsen et al.	382	154	07/08/1999

#### FOREIGN PATENT DOCUMENTS

EXAM. INIT.	REF. DES.	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION
	B1						
	B2						

#### OTHER ART (Author, Title, Journal, Volume, Pertinent Pages, & Date)

	C1	
EXAMINER	DATE CONSIDERED	
<i>M.2nd Stak</i>	3-31-06	

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